

10 ps timing with 3D trench silicon pixel sensors

57 mV

57 mV

A. Bellora, F. Borgato, M. Boscardin, D. Brundu, <u>A. Cardini</u>, G.M. Cossu, G.-F. Dalla Betta, M. Garau, L. La Delfa, A. Lampis, A. Lai, A. Loi, R. Mulargia, M. Obertino, S. Ronchin, G. Simi, S. Vecchi

57 mV-





Outline

- Challenges in tracking at high luminosities
- The TimeSPOT 3D trench pixel design
- New experimental results
- Conclusions and outlook



Present and future challenges in tracking

- Future and today's upgraded colliders will operate at extremely high instantaneous luminosities
 - Very important radiation damage to tracking detectors
 - Extremely difficult event reconstruction due to large pile-up → adding the time information (at the track or hit level) will help recovering tracking and vertexing capabilities
- ATLAS & CMS Phase-II upgrades (2026): mostly "traditional" tracker + single timing layer
 - $\sigma_t \approx 30 \text{ ps}, \sigma_s \approx 100\text{-}300 \text{ }\mu\text{m}, \text{F} \approx 10^{15} \text{ 1 MeV } n_{eo}/\text{cm}^2$
- LHCb Upgrade-2 (2030s): time information on each pixel
 - σ_t = 30-50 ps, $\sigma_s \approx 10 \ \mu m$, F = 10^{16} to 10^{17} 1 MeV n_{eo}/cm^2
- FCC-hh (2040s ?): further improve the radiation hardness
 - σ_t = 10-20 ps, $\sigma_s \approx 10 \ \mu m$, F = 10¹⁷ to 10¹⁸ 1 MeV n_{e0}/cm²

Spatial resolution, time precision and radiation hardness are required at the same time!

Efficiency 8.0

0.2

A. Cardini / Il

foil 150um

200ntracks

Adding the track time information

Adding time

information

LHCb

50

Upgrade I Upgrade II (no timing)

100

Upgrade II(50 ps/hit

150

Why 3D sensors?

- Original idea: S. Parker, 1997
- Key points
 - Short inter-electrode drift distance (tens of μm) give rise to extremely fast signals (d<<L)
 - Active volume and electrode shape can be designed for maximum performance
 - Unmatched radiation hardness (> 10¹⁷ 1MeV n_{eq}/cm², NIMA, 979 (2020) 164458)
 - 3D <u>columnar geometry</u> is a <u>production-ready</u> <u>technology</u> (ATLAS IBL, ATLAS-P2)



Limits to the time resolution of a 3D sensor

$$\sigma_t = \sqrt{\sigma_{tw}^2 + \sigma_{dr}^2 + \sigma_{un}^2 + \sigma_{ej}^2 + \sigma_{TDC}^2}$$



- σ_{dr} : jitter due to delta-rays negligible in a 3D sensor since all the charge deposits created at various depths contribute in the same way at the total signal because the charge collection occurs in a direction which is perpendicular to the charged particle path (and in general to the delta-rays produced)
- σ_{un} : non-uniformities in the weighting field and charge carrier velocities inside the detector sensitive unit give the ultimate limit on the time resolution that can be achieved with a 3D sensor
- $\sigma_{\rm ej}$: the analog noise of the preamplifier limits the sensor's time resolution and scales as $\sim \frac{\sigma_{noise}}{Amplitude}$

 $\sigma_{ t TDC}$: an adequate TDC will make this term negligible

$$\sigma_t \cong \sqrt{\sigma_{un}^2 + \sigma_{ej}^2}$$

Toward an optimized 3D sensor design

$\sigma_{ m ur}$

The detector signal is produced by the drift of the charge carriers created along the path of the (charged) particle across the pixel volume, which creates an instantaneous current i defined as

 $i = q \, \vec{E}_w \cdot \vec{v}_d$

where \vec{E}_w is the weighting field and \vec{v}_d is the carrier's drift velocity. To have <u>signals</u> that do not depend on where the charged particle has crossed the detector \rightarrow (1) make \vec{E}_w uniform by design and (2) work in a velocity saturation regime

$\sigma_{\mathsf{e}\mathsf{j}}$

To fully exploit the sensor capabilities, one needs to reduce the front-end amplifier noise (increasing the sensor's thickness is usually not an option)

→ TimeSPOT 3D trench-type silicon pixel detectors



Comparison between 3D geometries

- Simulated weighting field and velocity maps are much more uniform in the trench geometry both in magnitude and direction
- This is essential to guarantee, via Ramo theorem, signals which are largely independent on where the charged particles crossed the detector
- Simulated charge collection curves for 3000 minimum ionizing particles uniformly crossing a pixel over its active area, in the two different 3D pixel geometries: shorter and much more uniform charge collection time for the 3D trench geometry



La Biodola, 24MAY22

The trench-type TimeSPOT 3D pixels







- 55 μm x 55 μm pixels (to be compatible with existing FEE, for example the Timepix family ASICs)
- In each pixel a 40 μm long n++ trench is placed between continuous p++ trenches used for the bias
- 150 μm-thick active thickness, on a 350 μm-thick support wafer
- The collection electrode is 135 µm deep

The TimeSPOT 3D sensors fabrication

- Single sided (Si-Si) process with a support wafer
- Two batches were produced in 2019 and 2021 at Fondazione Bruno Kessler (FBK, Trento, Italy) using the Deep Reactive Ion Etching Technique (DRIE) Bosch process, 6" wafers
- High aspect ratios (30:1) and good dimensional uniformity
- Photolithography performed with a stepper machine (min. feature size 350nm, alignment accuracy 80nm, max. exposure area 2x2cm²)
- Many devices were designed and fabricated (single, double pixels, 10 pixel-strips, various pixel matrices, ...)





La Biodola, 24MAY22

Beam characterization of 3D trench pixels

We have characterized single-pixels and various pixel-strips (10-30 pixels) test structures, connected to custom-made front-end electronics boards featuring a two-stage transimpedence amplifier made with fast SiGe BJTs - to fully exploit the sensor speed one needs to readout the <u>sensor's current</u>



2022 SPS/H8 beam test (still ongoing)

- 180 GeV/C π^+ beam
- 10⁶ pions per spill (4 sec.) on a beam spot of 8mm RMS transverse size
- 2 MCP-PMTs on the beam line to time-stamp the arriving particle ($\sigma_{avg} = 5 \text{ ps}$)
- One fixed sensor. Another sensor mounted on piezoelectric slides to precisely align the two 3D structures with beam, all mounted in a RFshielded box
- Readout with 8 GHz bandwidth 20 GS/s scope, trigger on the AND of one 3D sensor and one MCP-PMT
- Possibility of operating the fixed sensor down to -40°C using dry ice to test irradiated sensors





Pixel waveforms data analysis

- For each sensor's waveform:
 - Signal baseline (red-dashed line) is evaluated on an event-byevent basis
 - The signal amplitude A is measured (w.r.t. to the event baseline)
 - Signal time of arrival evaluated with various methods:
 - <u>Leading-edge</u>: time at 20mV signal amplitude, linear interpolation around threshold
 - <u>Spline</u>: a traditional CFD at 35% with rising edge interpolated with a spline
 - <u>Reference</u>: subtract each waveform from a delayed (by half of the signal rise time) copy of itself, then on the resulting signal we trigger at X/2 height



Single 3D pixel - amplitude



- Non-irradiated pixel
- Normal pion incidence
- Unbiased trigger i.e. not on DUT
- The shape of the Landau distributions as a function of V_{bias} indicate a <u>very good</u> <u>sensor performance even at low V_{bias}</u>



14

Single 3D pixel – timing performances



- 3D pixel time distribution w.r.t MCP-PMTs: symmetric with only a small tail due to late signals
- Time distribution fitted with two gaussians, slightly time shifted, to include late signal contributions
- Excellent timing performances with CFD-based methods, but also using a leading edge algorithm



- Trenches (5 μm wide) are non-active volumes, channeled particles will not be seen
- Tilt the sensors with respect to normal incidence to recover geometrical efficiency
- Efficiency is measured by triggering on one pixel (55 μ m x 55 μ m, on piezos) centered on a triple strip (165 μ m x 550 μ m, the DUT) and counting the fraction of signals seen in the triple strip (on a single FE channel)
- Rotate the DUT around the trench direction La Biodola, 24MAY22

Efficiency: setup



Efficiency: method



- Plot the time distribution of **all triple-strip signals** w.r.t. MCP-PMTs and count as 'seen' the ones under the peak
- 3D pixel detection (geometrical) efficiency at normal incidence is in agreement with <u>calculated</u> <u>fraction of active area</u>

Efficiency: results



• The inefficiency (at normal incidence) due to the 3D pixel dead-area of the trenches is fully recovered by tilting the sensors around the trench axis at angles larger than 10°

Tilted sensors: timing performances



Does some tilt (rot. 1) slightly improves the time resolution?





Tilted sensors - time distributions





- In a tilted sensor, every charged track crosses both fast and less-fast regions of the pixels, thus providing a more uniform timing response
- Note that 3D detectors are required to be operated titled w.r.t normal incidence to recover the detection efficiency

Irradiated sensors – the setup

- 3D sensors were irradiated at the Triga Mark II reactor at the Jožef Stefan Institute in Lubjiana, Slovenjia
- Fluences: 10¹⁵, 10¹⁶ and 2.5·10¹⁶ 1MeV n_{eq}, sensors not annehaled
- 2.5·10¹⁶ 1MeV n_{eq} is what one would expect on LHCb vertex detector after LHC Run5 on innermost sensors
- Irradiated sensors tested below -20°C to reduce leakage current
- Characterization of irradiated single pixels and triple-pixel-strips structures



Irradiated sensors – working point



• A larger bias voltage is required to recover the signal amplitude for irradiated sensors

Irradiated sensors – timing performance



- Excellent time resolution (σ_{eff} = 11 ps) measured at 150V on single pixels irradiated with fluences of 2.5·10¹⁶ 1-MeV neutron equivalent
- Again, there are indications that a tilted sensor even performs slightly better than at normal incidence



 The inefficiency (at normal incidence) due to the dead-area of the trenches is fully recovered by tilting the sensors around the trench axis also for sensors irradiated with fluences of 2.5·10¹⁶ 1-MeV neutron equivalent

Conclusions

- Unprecedented results on trench 3D trend silicon pixels timing performances have been presented
- The time resolution of a single 3D trench pixel sensor was measured at SPS/H8 with a 180 GeV/c π^+ beam and found to be of about 11ps @ V_{bias} = 100V (sensor intrinsic + FEE noise)
- The sensor detection efficiency is fully recovered for incident angles larger than 10° with respect to normal incidence
- Sensors irradiated at a fluence of 2.5·10¹⁶ 1-MeV neq at V_{bias} exceeding 100V perform as the nonirradiated sensors, both in timing performances and in efficiency
- **3D devices** confirm their theoretical excellent performance in timing and the trench geometry appears to be the right direction to go
- **VERY IMPORTANT**: The front-end electronics is now the limiting factor to the system performance

... and Outlook

- The TimeSPOT collaboration has developed an ASIC (CMOS 28nm) to read a small pixel matrix → see A. Lai poster "Timespot1: an ASIC for high-resolution timing and highrates in 28-nm CMOS technology" on Friday
- 3D pixel matrices has just been bumpbonded to ASICs by IZM and the assemblies will be tested in the next months in the laboratory and on the beam at SPS/H8 in October 2022
- More news soon... stay tuned!





Thank you very much!

Publications by the TimeSPOT Collaboration

- 3D trenched-electrode sensors for charged particle tracking and timing, NIM A, (2019)
- Simulation of 3D-Silicon sensors for the TIMESPOT project NIMA, 936-, (2019)
- Development of 3D trenched-electrode pixel sensors with improved timing performance JINST, 14-, C07011 (2019)
- Sensors, electronics and algorithms for tracking at the next generation of colliders NIMA, 927-, (2019)
- Combined TCAD and Geant4 simulations of diamond detectors for timing applications NIMA, 936-, (2019)
- A Timing Pixel Front-End Design for HEP Experiments in 28 nm CMOS Technology, 15th Conference on Ph.D. Research in Microelectronics and Electronics, 2019
- First results of the TIMESPOT project on developments on fast sensors for future vertex detectors, NIMA, 2020
- Timing characterisation of 3D-trench silicon sensors, JINST, 2020
- Intrinsic time resolution of 3D-trench silicon pixels for charged particle detection, arXiv:2004.10881, JINST, 2020
- High-resolution timing electronics for fast pixel sensors, arXiv:2008.09867, to appear in JINST
- A. Loi et al., Timing Optimisation and Analysis in the Design of 3D silicon sensors: the TCoDe Simulator, JINST (2021) 16:P02011
- D. Brundu et al., Accurate modelling of 3D-trench silicon sensor with enhanced timing performance and comparison with test beam measurements, JINST 16 (2021) 09, P09028.
- L. Piccolo et al., First Measurements on the Timespot1 ASIC: a Fast-Timing, High-Rate Pixel-Matrix Front-End, arXiv:2201.13138
- Brundu D, et al. (2022) Modeling of Solid-State Detectors Using Advanced Multi-Threading: The TCoDe and TFBoost Simulation Packages. Front. Phys. 10:804752. doi: 10.3389/fphy.2022.804752



Backup Slides

Comparison between 3D geometries



- The time for total charge collection varies strongly as a function of the particle impact point on the pixel in the 5 columns geometry
- This dispersion will strongly affect the overall pixel time resolution
- The "planar" trench design provides a very fast and uniform charge collection time

DC electrical characterization of 3D trench pixels



<u>IV-curves</u> on 18x18 pixel matrices (pixels connected with temporary metal): ~10 pA/pixel – good!





Measured <u>capacitance</u> ~100 fF/pixel, in agreement with simulation

Fitting the time distribution: $\sigma_{ m eff}$



$$(\sigma_t^{\text{eff}})^2 = f_1(\sigma_1^2 + \mu_1^2) + (1 - f_1) \cdot (\sigma_2^2 + \mu_2^2) - \mu^2$$

where f_1 is the fraction of the Gaussian core and μ is defined as

 $\mu = f_1 \mu_1 + (1 - f_1) \cdot \mu_2$

 $\sigma_{\rm eff}$ takes into account the two-Gaussian behaviour